

**Notice of References Cited**

Application/Control No.

09/605,414

Applicant(s)/Patent Under  
Reexamination  
LEE ET AL.

Examiner

Polin Chieu

Art Unit

2615

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,124,807	06-1992	Dunlap et al.	386/39
	B	US-5,126,893	06-1992	Choi, Young-jun	360/67
	C	US-5,598,273	01-1997	Kurisaki et al.	386/9
	D	US-4,556,917	12-1985	Shibata et al.	386/29
	E	US-5,608,531	03-1997	Honda et al.	386/1
	F	US-5,606,424	02-1997	Jung, Mun-joo	386/26
	G	US-5,200,835	04-1993	Sakamoto, Etsurou	386/1
	H	US-6,078,720	06-2000	Lee et al.	386/4
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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